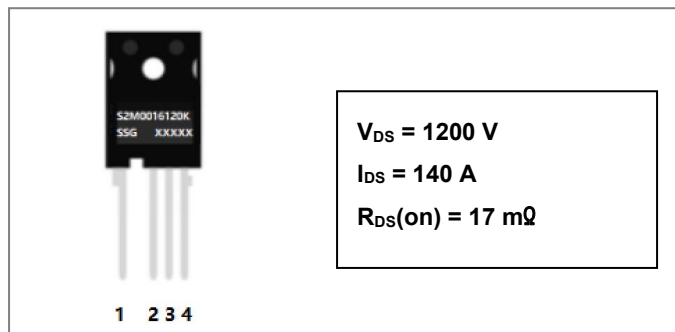


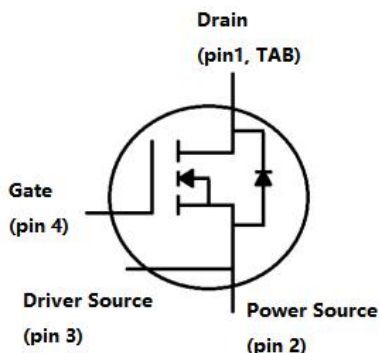
S2M0016120K-1 **1200V SiC POWER MOSFET**



Description

S2M0016120K-1 is single SiC Power MOSFET packaged in TO-247-4 case. The device is a high voltage n-channel enhancement mode MOSFET that has very low total conduction losses and very stable switching characteristics over temperature extremes. The S2M0016120K-1 is ideal for energy sensitive, high frequency applications in challenging environments.

Circuit Diagram



Features

- Positive temperature characteristics, easy to parallel.
- Low on-resistance Typ. $R_{DS(on)} = 17\text{m}\Omega$.
- Fast switching speed and low switching losses.
- Very fast and robust intrinsic body diode.
- Process of non-bright Tin electroplatin

Applications

- EV Fast Charging Modules
- EV On Board Chargers
- Solar Inverters
- Online UPS/Industrial UPS
- SMPS (Switch Mode Power Supplies)
- DC-DC Converters
- ESS (Energy Storage Systems)

Maximum Ratings(T=25°C unless otherwise specified)

Characteristics	Symbol	Condition	Max.	Units
Drain Source Voltage	V_{DSS}	$V_{GS} = 0\text{V}$, $I_{DS} = 100\mu\text{A}$, $T_C = 25^\circ\text{C}$	1200	V
Gate Source Voltage	V_{GSS}	$T_C = 25^\circ\text{C}$, Absolute maximum values, AC ($f > 1\text{Hz}$)	-10 to +25	V
Gate Source Voltage	V_{GSOP}	$T_C = 25^\circ\text{C}$ Recommended Operational Values	-5 to +20	V
Continuous Drain Current	I_D	$V_{GS} = 20\text{V}$, $T_C = 25^\circ\text{C}$	140	A
	I_D	$V_{GS} = 20\text{V}$, $T_C = 100^\circ\text{C}$	99	A
Pulsed Drain Current	$I_{D,pulse}$	$T_C = 25^\circ\text{C}$	250	A
Power Dissipation	P_D	$T_C = 25^\circ\text{C}$	517	W

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Electrical Characteristics(T=25°C unless otherwise specified)

Characteristics	Symbol	Condition	Min.	Typ.	Max.	Unit
Drain Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0V, I_D = 100\mu A$	1200			V
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 23mA$	1.8	2.55	3.6	V
		$V_{DS} = V_{GS}, I_D = 23mA, T_J = 175^\circ C$		1.85		V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 1200V, V_{GS} = 0V$		1	10	μA
Gate Source Leakage Current	I_{GSS}	$V_{GS} = 20V, V_{DS} = 0V$		10	250	nA
Drain Source On-State Resistance	$R_{DS(on)}$	$V_{GS} = 20V, I_D = 75A$	11.2	17	23	m Ω
		$V_{GS} = 18V, I_D = 75A$		19		m Ω
		$V_{GS} = 20V, I_D = 75A, T_J = 175^\circ C$		28		m Ω
		$V_{GS} = 18V, I_D = 75A, T_J = 175^\circ C$		29		m Ω
Transconductance	gfs	$V_{DS} = 20V, I_D = 75A$		24		S
		$V_{DS} = 20V, I_D = 75A, T_J = 175^\circ C$		18		S
Input Capacitance	C_{ISS}	$V_{GS} = 0V,$		4540		pF
Output Capacitance	C_{OSS}	$V_{DS} = 1000V$		210		
Reverse Transfer Capacitance	C_{RSS}	$V_{AC} = 25mV$		29.3		
C _{OSS} Stored Energy	E_{OSS}	$f = 100kHz$		122		μJ
Turn-On Switching Energy	E_{ON}	$V_{DS} = 800V, V_{GS} = -5/+20V$ $I_D = 75A, R_{G(ext)} = 2.5\Omega$		0.44		mJ
Turn-Off Switching Energy	E_{OFF}	$L = 65.7\mu H, T_J = 25^\circ C$		0.44		
Turn-On Delay Time	$t_{d(on)}$	$V_{DS} = 800V, V_{GS} = -5/20V$		13.76		ns
Rise Time	t_r	$I_D = 75A, R_{G(ext)} = 2.5\Omega, L = 67.5\mu H$		21.12		
Turn-Off Delay Time	$t_{d(off)}$	Inductive Load Timing relative to VDS Per IEC60747-8-4 pg 83		33.92		
Fall Time	t_f			8.96		
Internal Gate Resistance	$R_{G(int)}$	$f = 1MHz, V_{AC} = 25mV, D-S short$		1.5		Ω
Gate to Source Charge	Q_{gs}	$V_{DS} = 800V, V_{GS} = -5/20V$		290		nC
Gate to Drain Charge	Q_{gd}	$I_D = 75A$		37.2		
Total Gate Charge	Q_g			285		

Reverse Diode Characteristics:

Characteristics	Symbol	Condition	Typ.	Max.	Units
Diode Forward Voltage	V_{SD}	$V_{GS} = -5V, I_{SD} = 37.5A$	3.5		V
	V_{SD}	$V_{GS} = -5V, I_{SD} = 37.5A, T_J = 175^{\circ}C$	3.0		V
Continuous Diode Forward Current	I_S	$V_{GS} = -5V, T_C = 25^{\circ}C$		112	A
Reverse Recovery Time	t_{rr}	$V_{GS} = -5V, I_{SD} = 75A, T_J = 175^{\circ}C$	15		ns
Reverse Recovery Charge	Q_{rr}	$V_R = 800V$	201		nC
Peak Reverse Recovery Current	I_{mm}	$diff/dt = 2664A/\mu s$	21		A

Thermal-Mechanical Specifications:

Characteristics	Symbol	Condition	Specification	Units
Junction Temperature	T_J	-	-55 to +175	$^{\circ}C$
Storage Temperature	T_{stg}	-	-55 to +175	$^{\circ}C$
Typical Thermal Resistance Junction to Case	$R_{\theta JC}$	DC operation	0.29	$^{\circ}C/W$
Typical Thermal Resistance Junction to Ambient	$R_{\theta JA}$		38.85	$^{\circ}C/W$

Ordering Information:

Device	Package	Shipping
S2M0016120K-1	TO-247-4	30pcs/tube

Marking Diagram


Where XXXXX is YYWWL

S2M = Device Type
 0016 = $R_{DS(on)}$
 120 = Reverse Voltage (1200V)
 K = Package
 SSG = SSG
 YY = Year
 WW = Week
 L = Lot Number

Cautions: Molding resin
 Epoxy resin UL:94V-0

Ratings and Characteristics Curves

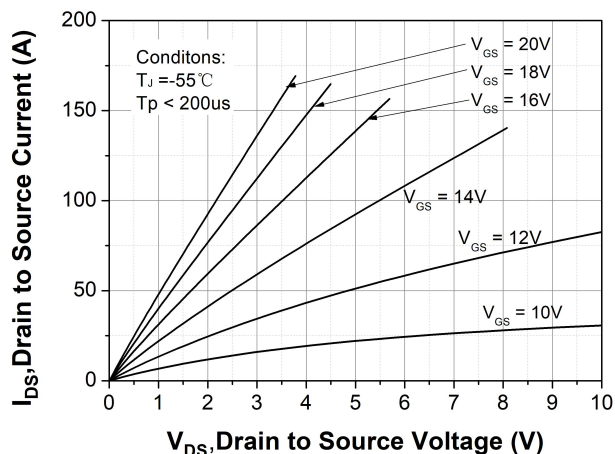


Figure 1. Output Characteristics $T_J = -55^\circ\text{C}$

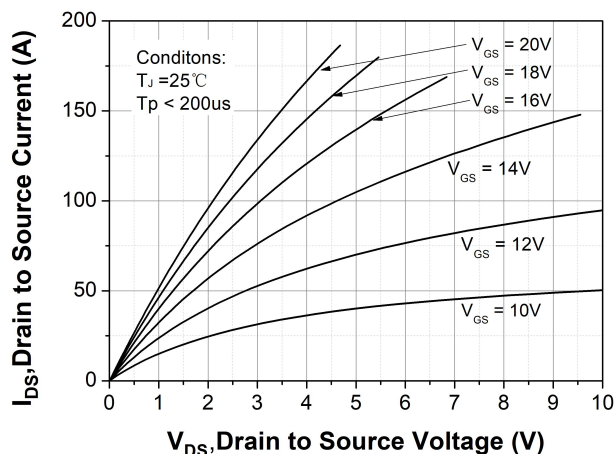


Figure 2. Output Characteristics $T_J = 25^\circ\text{C}$

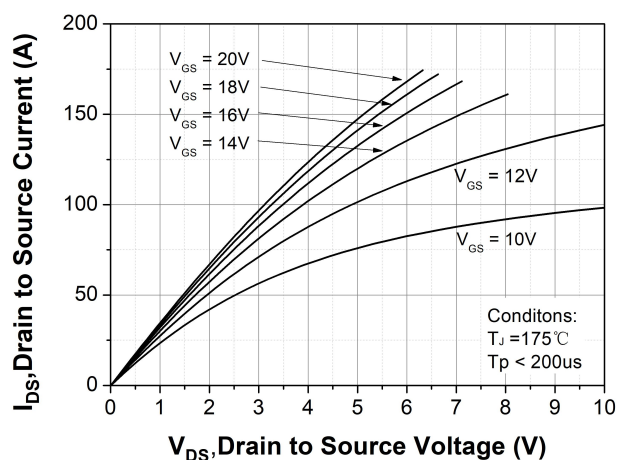


Figure 3. Output Characteristics $T_J = 175^\circ\text{C}$

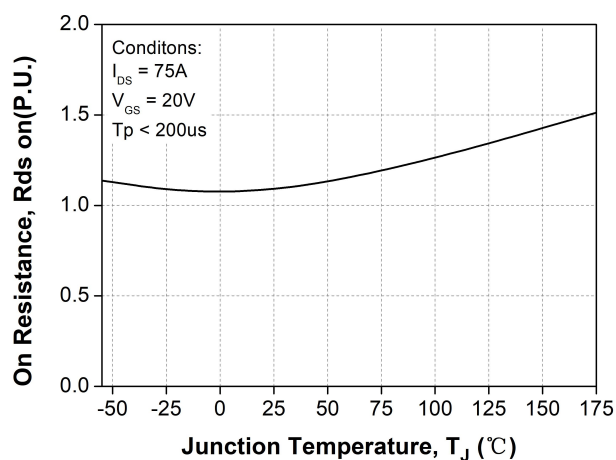
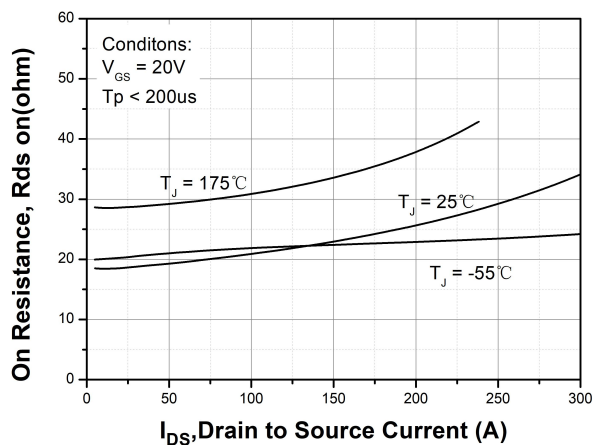
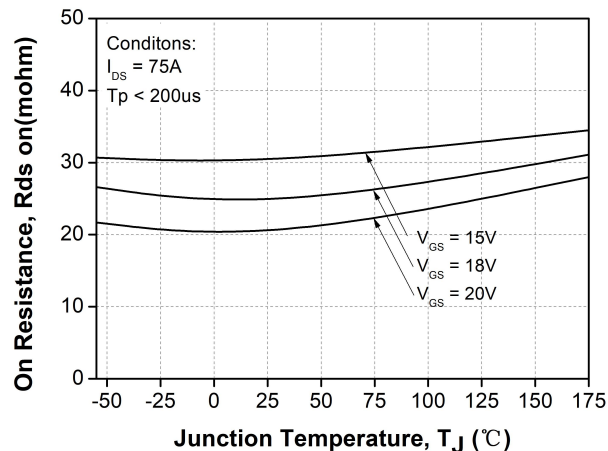


Figure 4. Normalized On-Resistance vs. Temperature



**Figure 5. On-Resistance vs. Drain Current
For Various Temperatures**



**Figure 6. On-Resistance vs. Temperature
For Various Gate Voltage**

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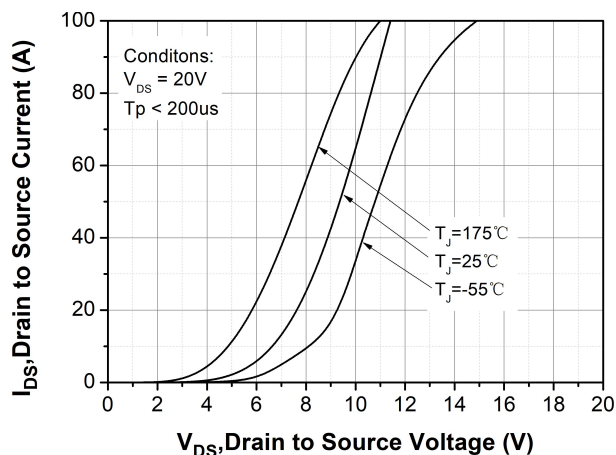


Figure 7. Transfer Characteristic for Various Junction Temperatures

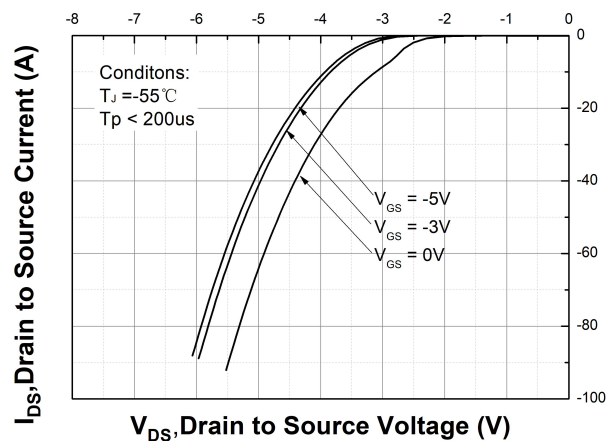


Figure 8. Body Diode Characteristic at $T_J = -55^\circ C$

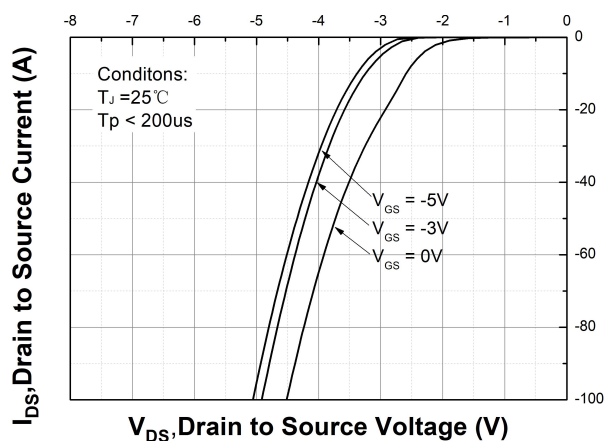


Figure 9. Body Diode Characteristic at $T_J = 25^\circ C$

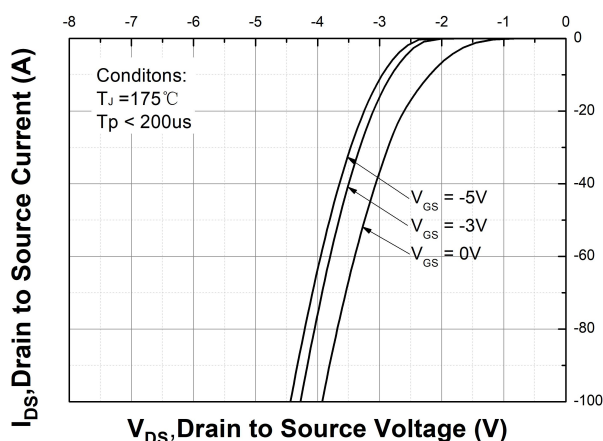


Figure 10. Body Diode Characteristic at $T_J = 175^\circ C$

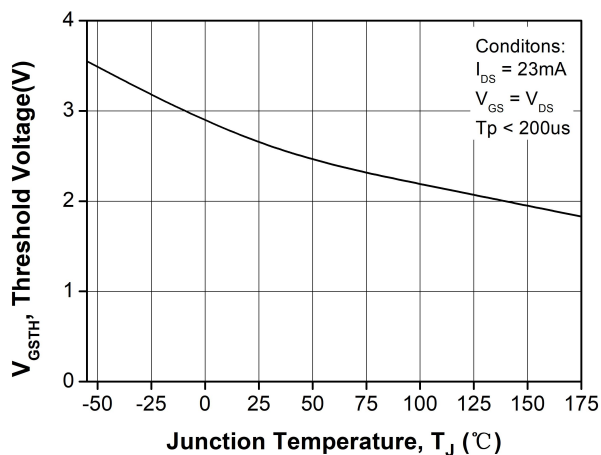


Figure 11. Threshold Voltage vs. Temperature

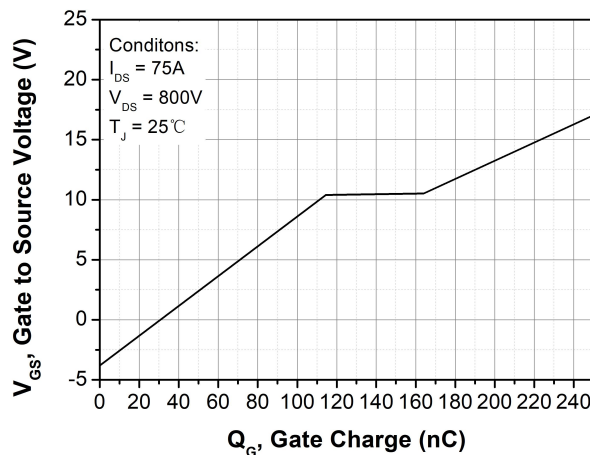


Figure 12. Gate Charge Characteristic

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RoHS

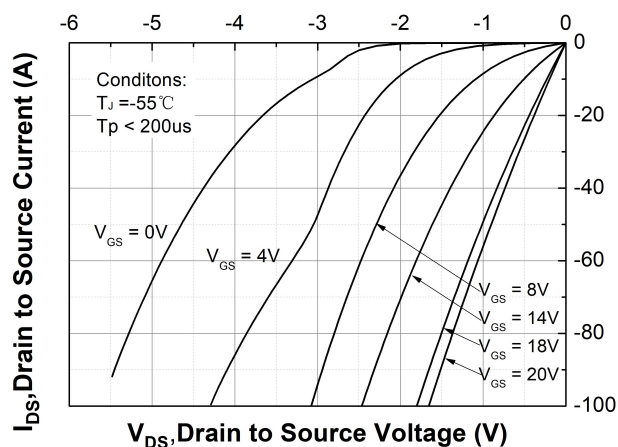


Figure 13. 3rd Quadrant Characteristic at $T_J = -55^\circ\text{C}$

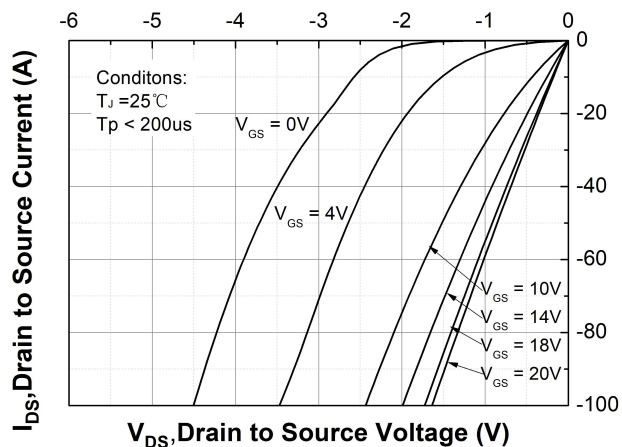


Figure 14. 3rd Quadrant Characteristic at $T_J = 25^\circ\text{C}$

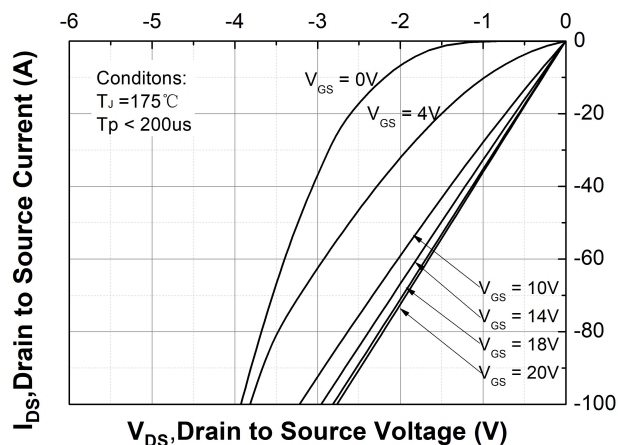


Figure 15. 3rd Quadrant Characteristic at $T_J = 175^\circ\text{C}$

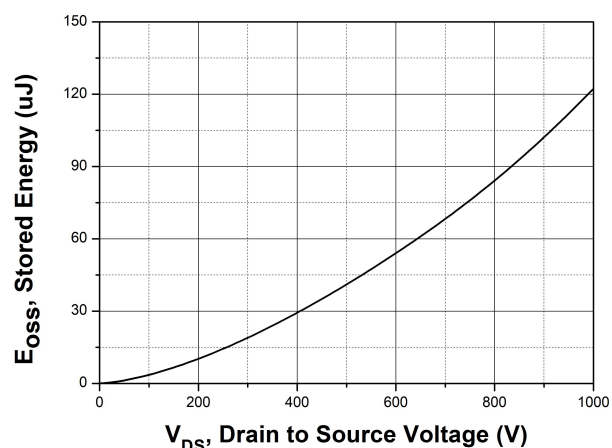


Figure 16. Output Capacitor Stored Energy

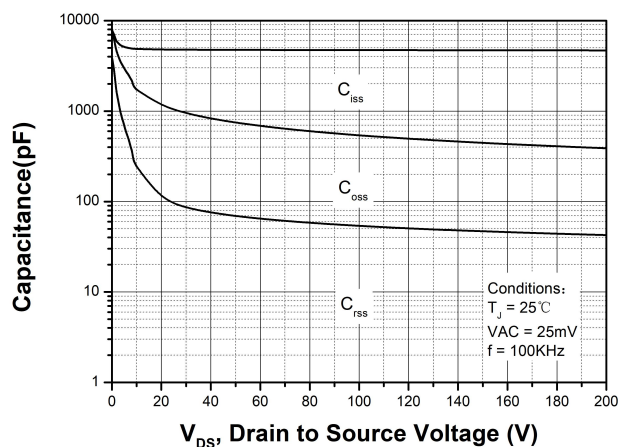


Figure 17. Capacitances vs. Drain-Source Voltage (0 - 200V)

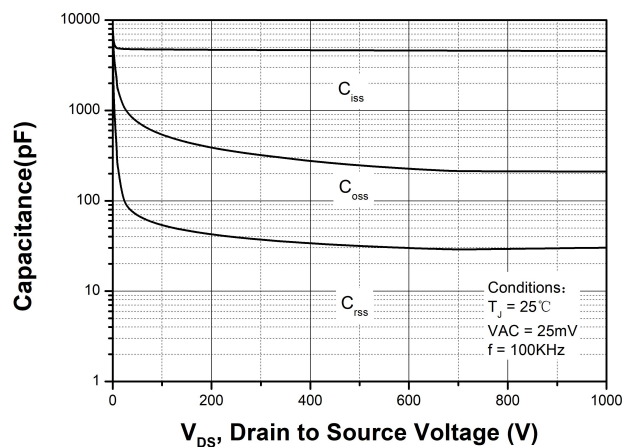


Figure 18. Capacitances vs. Drain-Source Voltage (0 - 1000V)

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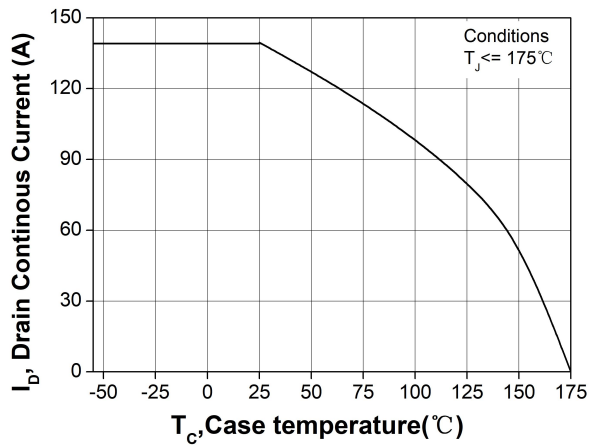


Figure 19. Continuous Drain Current Derating vs. Case Temperature

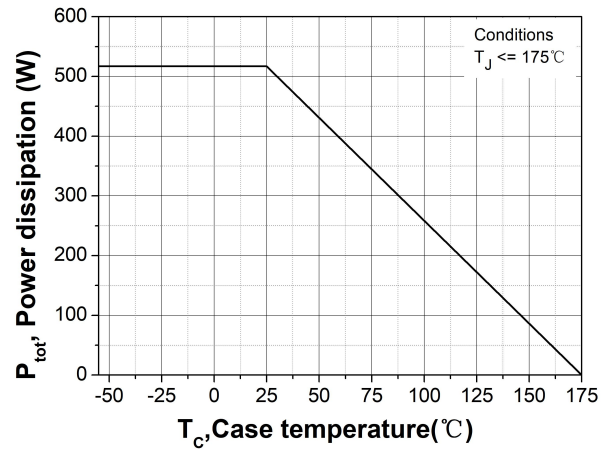


Figure 20. Maximum Power Dissipation Derating vs. Case Temperature

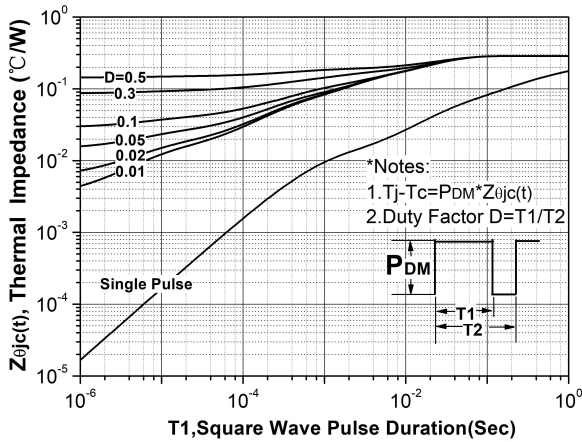


Figure 21. Transient Thermal Impedance (Junction - Case)

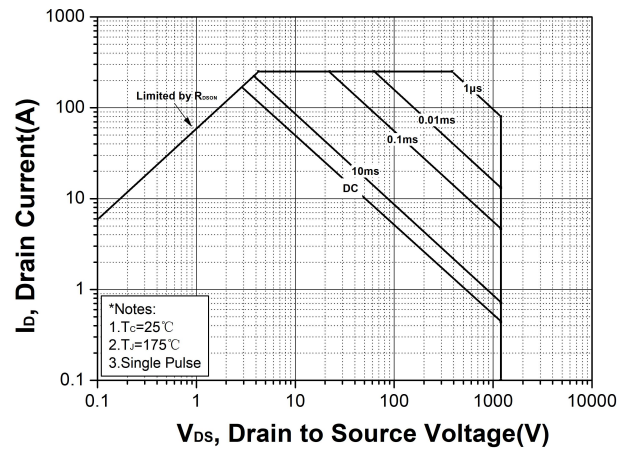


Figure 22. Safe Operating Area

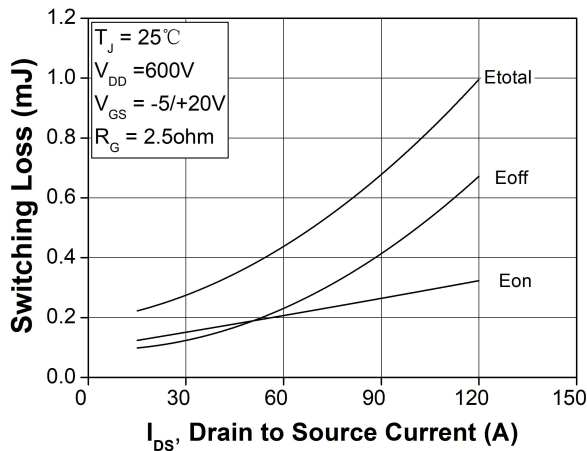


Figure 23. Clamped Inductive Switching Energy vs. Drain Current ($V_{DD} = 600V$)

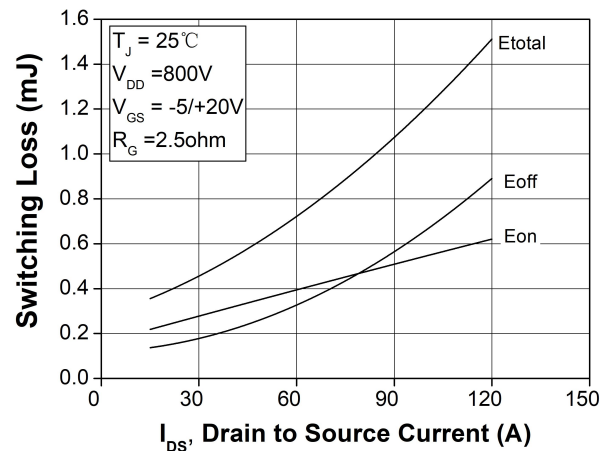


Figure 24. Clamped Inductive Switching Energy vs. Drain Current ($V_{DD} = 800V$)

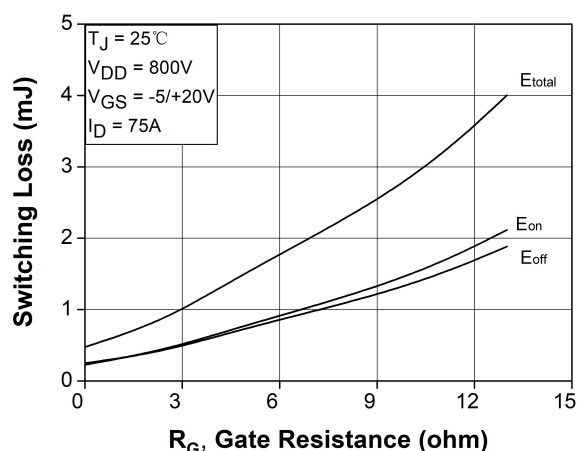


Figure 25. Clamped Inductive Switching Energy vs. $R_{G(\text{ext})}$

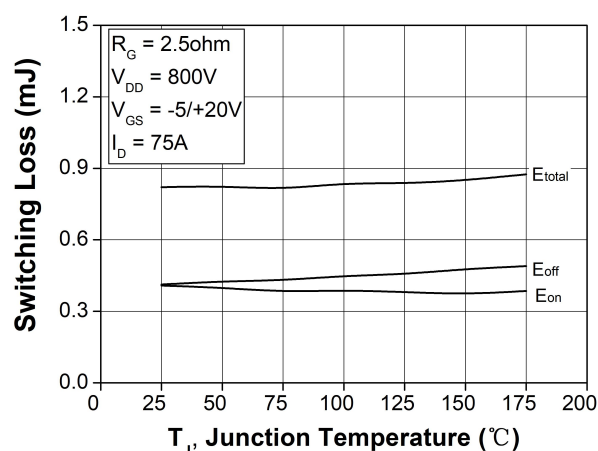


Figure 26. Clamped Inductive Switching Energy vs. Temperature

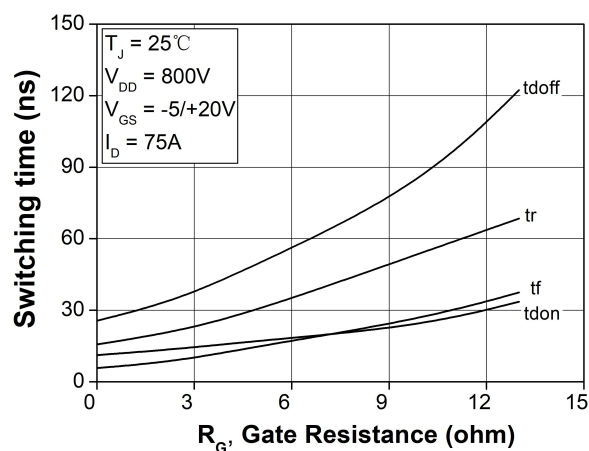


Figure 27. Switching Times vs. $R_{G(\text{ext})}$

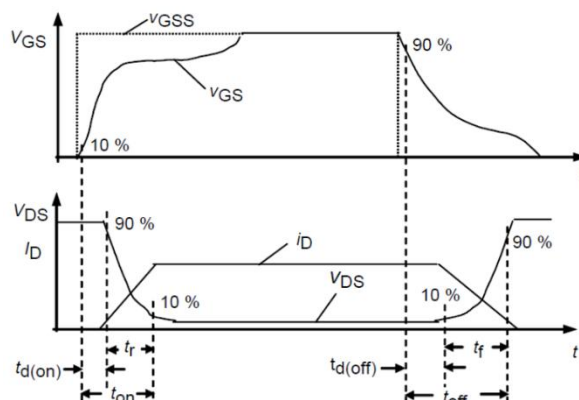
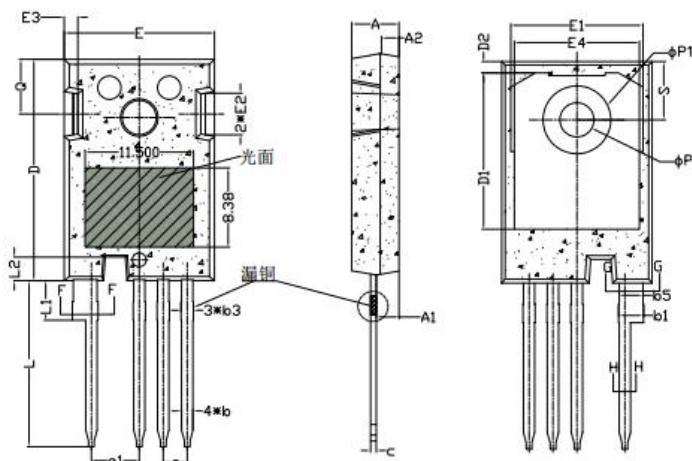


Figure 28. Switching Times Definition

Mechanical Dimensions TO-247-4



Symbol	In mm		
	Min	Nom	Max
A	4.83	5.00	5.21
A1	2.29	2.41	2.54
A2	1.91	2.00	2.16
b'	1.07	1.20	1.28
b	1.07	1.20	1.33
b1	2.39	2.67	2.94
b2	2.39	2.67	2.84
b3	1.07	1.30	1.60
b4	1.07	1.30	1.50
b5	2.39	2.53	2.69
b6	2.39	2.53	2.64
c	0.55	0.60	0.68
c1	0.55	0.60	0.65
D	23.30	23.45	23.60
D1	16.25	16.55	17.65
D2	0.95	1.19	1.25
E	15.75	15.94	16.13
E1	13.10	14.02	14.15
E2	3.68	4.40	5.10
E3	1.00	1.45	1.90
E4	12.38	13.26	13.43
e	2.54 BSC		
e1	5.08 BSC		
L	17.31	17.57	17.82
L1	3.97	4.19	4.37
L2	2.35	2.50	2.65
ΦP	3.51	3.61	3.65
ΦP1	7.19 REF		
Q	5.49	5.79	6.00
S	6.04	6.17	6.30

Technical Data
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RoHS

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